

# MICROWAVE CHARACTERIZATION OF PARYLENE C DIELECTRIC AND BARRIER PROPERTIES

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## ABSTRACT

Parylene C thin films are commonly used as a passivation layer, protective coating, or substrate material in implantable medical devices. However, fluid or vapor may permeate through Parylene C films over time through defects, film edges, or bulk diffusion and lead to device failure *in vivo*. Such failure can be difficult to detect using electrochemical impedance spectroscopy (0.1 Hz – 1 MHz) which does not capture the dielectric contributions of fluid at higher frequencies.

We present a method for tracking broadband (1 MHz – 110 GHz) microwave dielectric properties of polymer-fluid interfaces. Using 2D electromagnetic modeling, we simulated measurement sensitivity to potential changes in Parylene C film dielectric properties and estimated sensitivity to changes in film relative permittivity as small as  $\pm 0.1$  and fluid layers under films as small as 5 nm. Results were used to aid in the interpretation of measurements of soaked Parylene C films. These results are informative development of robust, hermetic polymer films in implantable medical devices and other RF applications in the analysis of complex fluids.

## KEYWORDS

Parylene C, Thin film, Broadband, Microwave, Dielectric, Spectroscopy, Interfaces, Microfluidic

## INTRODUCTION

Parylene C is used as a barrier and insulation material in medical implants because it is biocompatible, flexible, and coats conformally [1]. Parylene C is a popular substrate material in thin film implants because it is compatible with microfabrication processes [2]. However, the barrier properties of Parylene thin films may degrade within months *in vivo* [3], leading to electrical shorting and device failure. Contributing mechanisms may include film oxidation, poor film adhesion or delamination, and fluid permeation or diffusion.

Many studies have examined the dielectric and barrier properties of Parylene C films *in vitro* via electrochemical impedance spectroscopy (EIS) [4][5]. However, EIS is limited to frequencies (in the range of 0.1 Hz – 1 MHz) and is unable to capture phenomena that occur at higher frequencies, particularly dipolar relaxations, and ionic conduction. Wireless medical devices often employ radio-frequency data or power transfer, typically via transmission through biological tissue. At these frequencies, dipolar relaxations and ionic conduction contribute to dielectric loss, which causes signal attenuation and undesired tissue heating.

In contrast, microwave microfluidic spectroscopy

(MMS), utilizes a broader range of frequencies (40 kHz – 110 GHz) that can capture multiple physical phenomena, such as electric double layer formation, ionic conduction, ion pairing, and dipolar relaxation [6]. MMS measures complex scattering-parameters (S-parameters) of coplanar waveguides (CPWs) coupled with microfluidic structures. CPWs provide a simple geometry to carry high frequency signals [7], and the S-parameter data can be fit to a transmission line model from which dielectric properties can be extracted.

The broadband properties of Parylene C-coated CPWs after long-term exposure to water or ionic fluid were measured using MMS in our previous work [8]. However, mapping S-parameters to physical changes in the films was unclear. Previously, we evaluated the fit of MMS measurements to a transmission line model. In this study, we extended on this capability and performed parametric simulations to quantify the sensitivity of MMS to potential physical changes in the Parylene C film from fluid exposure, such as delamination, fluid intrusion, film swelling, and shifts in film permittivity. Parametric simulation results were used to aid interpretation of measured S-parameters and determine if any significant changes in film dielectric properties were induced by fluid exposure. Discerning the true physical changes is crucial in identifying failure mechanisms and informing mitigation strategies to achieve robust polymer films for implantable medical devices.

## MATERIALS AND METHODS

### Fabrication

We fabricated Parylene C-coated platinum CPWs as in [9] on a fused silica wafer via a metal lift-off followed by chemical vapor deposition of Parylene C. We fabricated reference wafers with gold CPWs to calibrate S-parameters to the probe tips of the vector network analyzer (VNA) probes. We cast a polydimethylsiloxane (PDMS) microfluidic cover in a 3D-printed mold and integrated the cover on CPWs for MMS (Fig. 1a, b).

### Measurement

We obtained S-parameter measurements (100 MHz – 110 GHz) using a VNA and were calibrated with multiline thru-reflect-line (TRL) and series resistor calibrations [12], leaving only the section shown in Fig. 1c as the device-under-test. Total measurement uncertainty was determined by compounding Type A and B uncertainties by a sum of root mean squares [8].

Measurements from our previous study [8] were used for analysis in this study. CPWs were soaked over 2 months in either deionized (DI) water at 20°C, 1×PBS (phosphate-

buffered saline) at 20°C, or 1×PBS at 37°C. The change in measured S-parameters following soaking were used to assess changes in film dielectric properties. Measured results were compared to simulated results.

### Simulation

We performed 2D electromagnetic simulations to model the broadband properties of the CPW microfluidic assembly (Fig. 1d). The assembly sections are defined in Fig. 2. Using the measured geometry and material properties (Table 1), we simulated the 2D electric field at the microfluidic channel to assess the contribution of the Parylene C film to the effective dielectric properties.

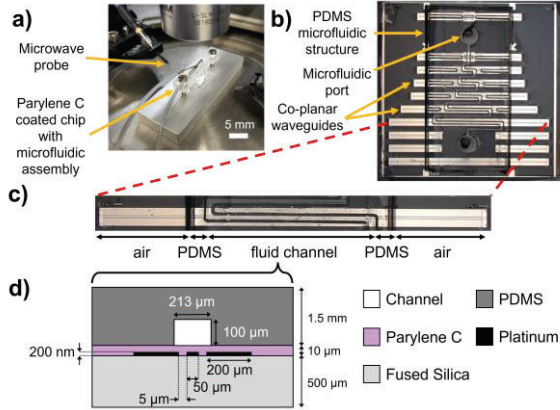


Figure 1: Measurement set-up of Parylene C coated CPW microfluidic assembly [8]. a) CPW with PDMS microfluidic assembly on the probe station. b) Top-down view of the assembly. c) Top-down view of a single coplanar waveguide (4.16 mm length). d) Illustrated cross-section at microfluidic channel with dimensions.

A dual Debye relaxation model (Eqn. 1) [9] was selected for DI water [10] and a Cole-Cole model (Eqn. 2) of 0.9% saline [11] for 1×PBS:

$$\epsilon_D(\omega) = \epsilon_\infty + \frac{\epsilon_s - \epsilon_2}{1 + i\omega\tau_2} + \frac{\epsilon_2 - \epsilon_\infty}{1 + i\omega\tau_2} \quad (1)$$

$$\epsilon_C(\omega) = \epsilon_\infty + \frac{\epsilon_s - \epsilon_\infty}{(1 + i\omega\tau_1)^{1-\alpha}} \quad (2)$$

where  $\epsilon_s$ ,  $\epsilon_2$ , and  $\epsilon_\infty$  are the low, intermediate, and high frequency permittivity values, respectively,  $\tau_1$  and  $\tau_2$  are relaxation time constants,  $\omega$  is the angular frequency, and  $\alpha$  is a factor of symmetrical broadening of the relaxation peak.

The fit of our measurements to a transmission line model was previously demonstrated by comparing simulated to measured S-parameters [8]. Similarly, we obtained transmission line circuit model elements  $R_i$ ,  $L_i$ ,  $C_i$ , and  $G_i$  for each section  $i$  in Fig. 2 from simulations. Then we computed each section's characteristic impedance  $Z_i$  and propagation constant  $\gamma_i$  [13]:

$$Z_i = \frac{\sqrt{R_i + i\omega L_i}}{\sqrt{G_i + i\omega C_i}} \quad (3)$$

$$\gamma_i = \sqrt{(R_i + i\omega L_i)(G_i + i\omega C_i)} \quad (4)$$

Table 1: Material properties for simulated CPWs.

Material	$\epsilon(\omega)$	$\sigma$ (S/m)
Silica	3.82	0
Platinum	1.00	$0.90 \times 10^7$
Parylene C	3.00	0
PDMS	2.77	0
DI H <sub>2</sub> O	Eqn. (1)[10]	0
1×PBS	Eqn. (2)[11]	1.60

Using  $Z_i$  and  $\gamma_i$ , we derived the transmission parameter matrix  $T_i$  and the impedance transformers  $Q_{Z_m}^{Z_n}$  for each transition of  $Z_i$  between sections:

$$T_i = \begin{bmatrix} e^{-\gamma_i l_i} & 0 \\ 0 & e^{\gamma_i l_i} \end{bmatrix} \quad (5)$$

$$Q_{Z_m}^{Z_n} = \frac{1}{2Z_m} \left| \frac{Z_m}{Z_n} \right| \sqrt{\frac{\text{Re}(Z_n)}{\text{Re}(Z_m)}} \begin{pmatrix} Z_n + Z_m & Z_n - Z_m \\ Z_n - Z_m & Z_n + Z_m \end{pmatrix} \quad (6)$$

where  $n$  and  $m$  denote transmission of a signal from section  $n$  to section  $m$ . Then we computed a T-matrix  $T_{all}$  representing the entire device in Fig. 2a, corrected to 50  $\Omega$  by cascading the T-matrices:

$$T_{all} = Q_{50\Omega}^1 T_1 Q_2^1 T_2 Q_3^2 T_3 Q_4^3 T_4 Q_3^4 T_3 Q_2^3 T_2 Q_1^2 T_1 Q_{50\Omega}^1 \quad (7)$$

where indices of each matrix correspond to section numbers in Fig. 2a. We converted T-matrices directly to S-parameters that model the CPW assembly in Fig. 1.

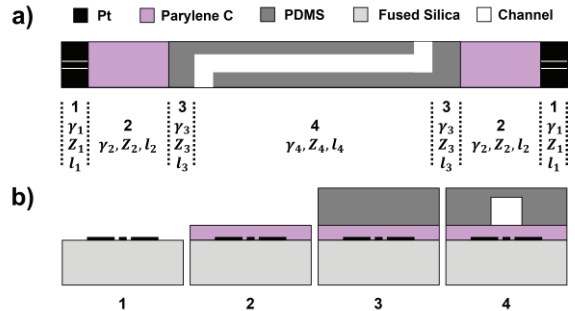


Figure 2: Diagram of each section of the CPW microfluidic assembly [8]. a) Top-down view of each section  $i$  with transmission line model quantities  $\gamma_i$  and  $Z_i$ , and line lengths  $l_i$ . b) Cross-section of each section  $i$ .

Parametric simulations were used on simplified model systems to assess the sensitivity of measured S-parameters to potential physical changes from fluid, including delamination, fluid intrusion, film swelling, and shifts in film permittivity (Fig. 3). Parylene film permittivity ( $\epsilon_{Parylene}$ ) was varied from 2.5 to 3.5. The thickness of DI water ( $h_{H2O}$ ), and PBS ( $h_{PBS}$ ) were varied from 0.001  $\mu\text{m}$  to 0.025  $\mu\text{m}$  and represent delamination from fluid. Similarly, the thickness of an air layer ( $h_{air}$ ) was varied from 0.01  $\mu\text{m}$  to 1  $\mu\text{m}$  to represent film delamination without fluid. Film thickness ( $h_{film}$ ) was varied from 0.01  $\mu\text{m}$  to 10  $\mu\text{m}$  to represent film swelling.

The linear magnitude of the S-parameters ( $|S_{11}|$  and  $|S_{21}|$ ) were used for computation to emphasize minute changes from parameter variation. The sensitivity to each parameter was evaluated by computing the change in broadband S-parameter magnitude:

$$\Delta|S| = |S|_i - |S|_0 \quad (8)$$

where  $|S|_i$  are the broadband linear magnitude S-parameters resulting from a parameter value  $i$  and  $|S|_0$  are the broadband linear magnitude S-parameters prior to any imposed conditions.

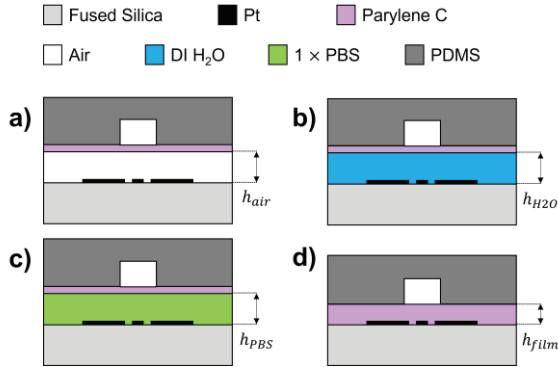


Figure 3: Parametric simulation model systems for S-parameter sensitivity to physical changes in the Parylene C film at the microfluidic channel. Uniform, progressive delamination of Parylene C with a) air, b) DI H<sub>2</sub>O, or c) 1×PBS underneath the film. D) Uniform film swelling.

## RESULTS AND DISCUSSION

The simulated electric field distributions in Fig. 4 correspond to the film parameters in Fig. 3. In Fig. 4a, the air layer results in a more broadly distributed electric field above the CPW due to the lower effective permittivity relative to the substrate. In Fig. 4b and 4c, the electric field is more tightly confined, likely due to the greater permittivity and additional dielectric loss contributed by the fluid layers.

The sensitivity of S-parameters to changes in the individual parameters of interest are shown in Fig. 5. Typical measurement uncertainty from measurements in [8] for  $S_{11}$  and  $S_{21}$  are overlaid in Fig. 5. The uncertainty varies across frequency and is minimal at around 5 to 9 GHz, primarily contributed from sources of Type A uncertainty. Changes in S-parameters at these frequencies are less likely to be compounded with measurement error and are thus more sensitive to true, dielectric changes in the film.

MMS was sensitive to a change in  $\epsilon_{\text{Parylene}}$  as small as  $\pm 0.1$ , where  $S_{21}$  at 6 GHz exceeded the measurement uncertainty (Fig. 5). In Fig. 5b, delamination with  $h_{\text{air}}$  as small as 10 to 50 nm yielded comparable results for  $S_{21}$  at 6 GHz. Sensitivity was greater when fluid was introduced (Fig. 5c, d), fluid layer thicknesses  $h_{\text{H}_2\text{O}}$  and  $h_{\text{PBS}}$  as small as 1 to 5 nm resulted in a change in  $S_{21}$  greater than the measurement uncertainty. Additionally, there is a unique, low-frequency dependence with PBS layer thickness, due to ionic conductivity. S-parameters in Fig. 5e was less sensitive to changes in film thickness and required an increase of at least 1  $\mu\text{m}$  in film thickness  $h_{\text{film}}$  to exceed measurement uncertainty.

Measured changes in S-parameters of Parylene C CPWs exposed to DI H<sub>2</sub>O and 1×PBS over 2 months from [8] is shown in Fig. 5f, for direct comparison to sensitivity

to each parameter of interest. For DI H<sub>2</sub>O and 1×PBS at 20°C, the change remained within the bounds of measurement uncertainty, suggesting no measurable change in the geometry or dielectric properties of the Parylene C film. For the film exposed to 1×PBS at 37°C, there was a slight change in S-parameters that exceeds the uncertainty at 5 to 9 GHz. Comparing this change to the simulated results in Fig. 5a-e suggests a significant change in effective permittivity. The slight vertical shift at 100 MHz to 1 GHz for 1×PBS in Fig. 5f may be indicative of an ionic conductivity as seen in Fig. 5d, suggesting there is likely an ingress of 1×PBS. Discerning the exact physical changes in the film requires additional characterization.

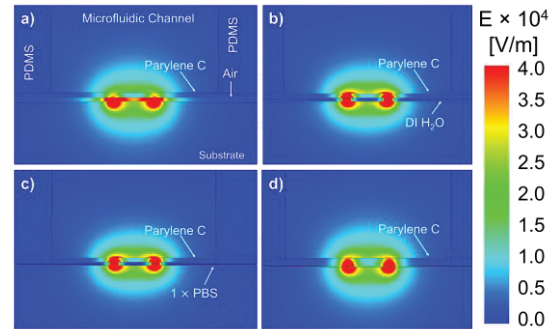


Figure 4: Parametric simulation electric field distributions at the microfluidic channel for a)  $h_{\text{air}}$ , b)  $h_{\text{H}_2\text{O}}$ , c)  $h_{\text{PBS}}$ , d) and  $h_{\text{film}}$ . The intensity of the electric field generated by the CPW is given as a gradient scale on the right.

In each case, sensitivity could be enhanced with further calibration as the S-parameters include redundant contributions from non-channel sections of the CPW. Sensitivity was greatest with the introduction of fluid, due to the large mismatch in dielectric properties between fluid and Parylene C or air. However, it is unknown how the dielectric properties of the film change from fluid present in the film matrix. Furthermore, shifts in film geometry will likely be more complex and non-uniform. Future experiments could validate whether the estimated sensitivity to each parameter is accurate, however replicating changes such as delamination in the film in a controlled, physical experiment is challenging. Direct measurement of sensitivity would introduce uncertainty with each measurement and would result in lower sensitivity than estimated here.

## CONCLUSION

We evaluated a method for measuring microwave-frequency dielectric properties of polymer-fluid interfaces. We estimated the measurement sensitivity to changes in relative permittivity as small as  $\pm 0.1$  or fluid layers as thin as 5 nm through parametric simulations. Simulation results were used to aid interpretation of previous measurements of Parylene C films soaked in DI water and 1×PBS. In future applications of our method, such as characterizing other polymer-fluid interfaces, we suggest performing a similar parametric analysis of sensitivity. Our results demonstrate our method is an effective technique for measuring and modeling microwave dielectric properties of polymer-fluid interfaces. Overall, our results are valuable

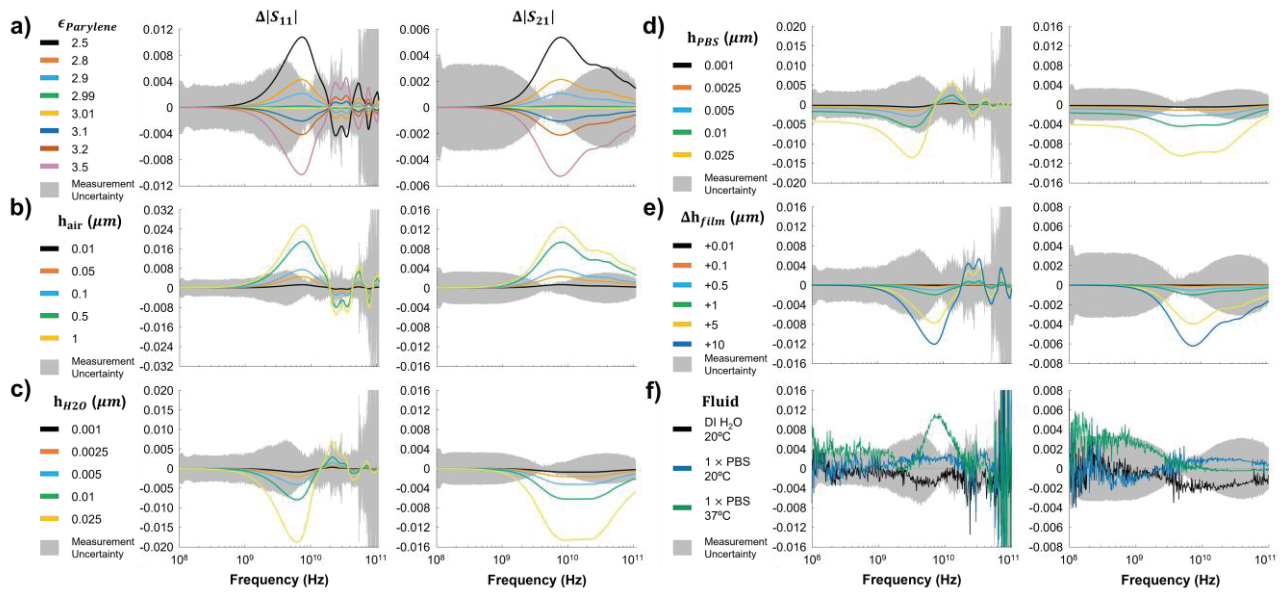


Figure 5: Simulated broadband sensitivity of  $S$ -parameter magnitude to a) Parylene C permittivity, b) delamination (air underneath), c) DI  $H_2O$  accumulation under film, d)  $1\times$ PBS accumulation under film, and e) film swelling. f) Measured changes in broadband  $S$ -parameters following soaking in several fluid soaking conditions [8]. Typical measurement uncertainty prior to soaking is overlaid in each case.

for the development of robust, wireless devices in fluid media such as implantable medical devices.

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